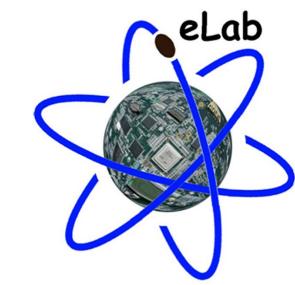


# Multi-Channel FPGA-Based Data-Acquisition-System for Time-Resolved Single-Photon Counting in Synchrotron Radiation Experiments

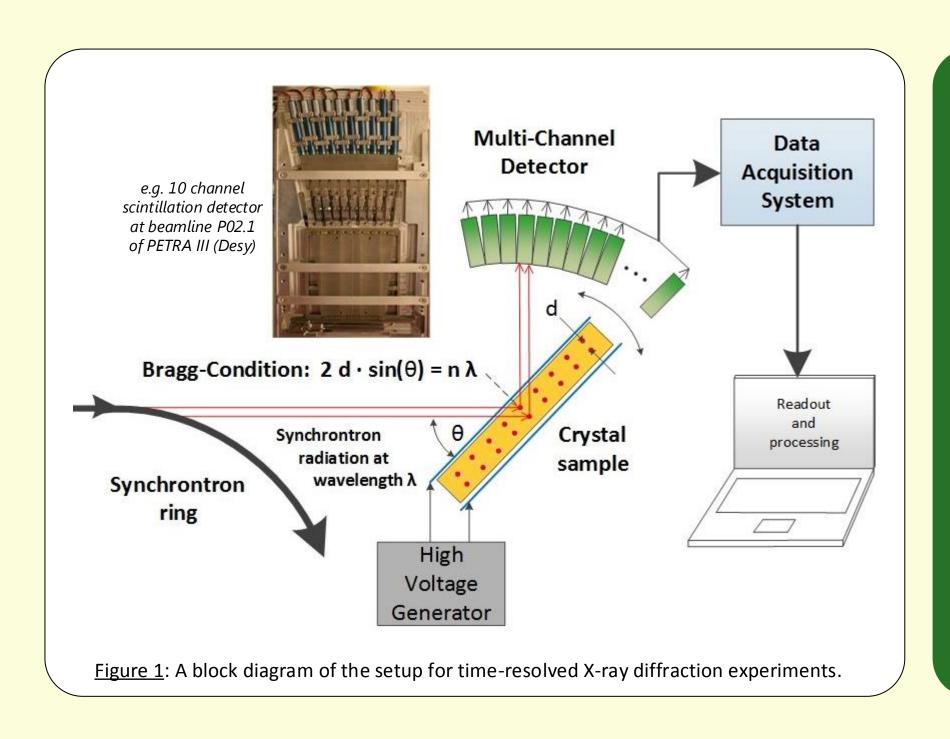




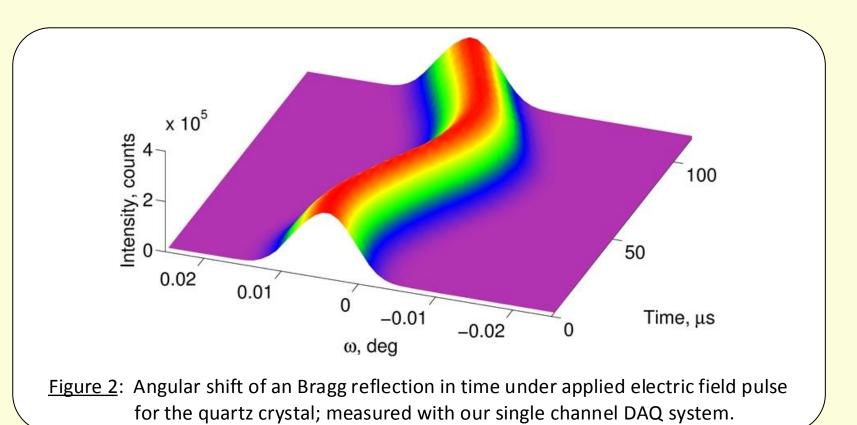
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# 1. Motivation: fundamental and applied science

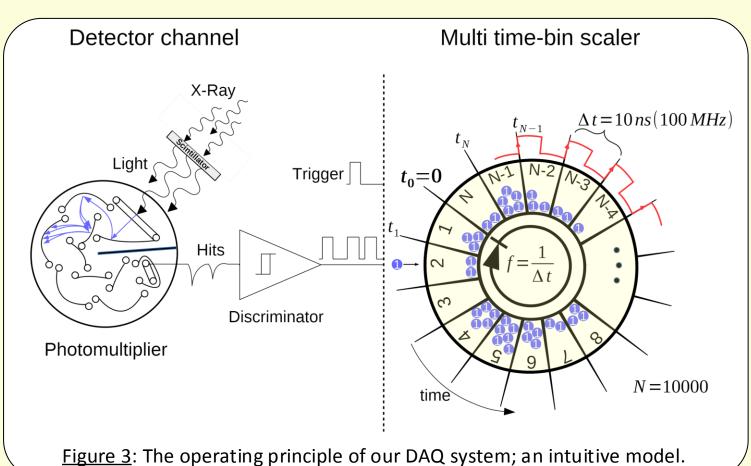


- Structural dynamics of crystals: the topic of high interest for X-ray crystallography.
- Studied by observing Bragg diffraction patterns with X-ray or synchrotron radiation under dynamically applied *external electric field perturbations* (~Hz to ~MHz); *Figure 1*.
- Different time scales on which crystals react to perturbations connect to different physical mechanisms describing response phenomena:
  - $\rightarrow$  Change of peak intensity  $\leftrightarrow$  electron and atomic dynamics with characteristic timescales of fs to ps.
  - > Intensity re-arrangement between peaks \(\lefta\) mesoscopic dynamics, e.g. domain wall motion with characteristic timescales below **ns** to **ms**.
  - > Angular shift of Bragg reflections \(\lefta\) lattice and domain macroscopic dynamics with characteristic timescales of **µs** to **ms** and beyond; *Figure 2*.
- Demand on new data acquisition electronics (DAQ systems) suitable for time-resolved measurements of Bragg diffraction patterns with <u>multi-channel point-detectors</u> simultaneously; currently 12 channels.



- Our new DAQ system: easily portable between synchrotron facilities and scalable in terms of detector channels.
- Used successfully for our novel time-resolved X-ray diffraction experiments at synchrotron facilities of PETRA III (DESY), BESSY II (Berlin) and ESRF (Grenoble).

#### 2. Operating Principle of our DAQ system



- scintillation material. • Light photons converted into electrical pulses by photomultiplier. Pulses standardized by a discriminator and applied

to the DAQ electronics.

X-ray diffraction photons converted into light photons by

- An *intuitive model* for one detector channel; Figure 3:
- stepwise rotating wheel with time-bin compartments of 10 ns width, moved synchronously by 100 MHz clock.
- 10 000 wheel compartments, each one capable of storing photon hits arriving in a respective time bin of 10 ns.
- Trigger pulse resets time and starts data collection.
- Photon arrival time analysed by the stepping wheel:
- ❖ hits injected into corresponding time compartments and summed up with counts already gathered.

The **system** of 12 parallel working channels.

#### 3. System Architecture

Diffractometer

- > Designed in VHDL (hardware description language)
- > Implemented on FPGA (field programmable gate array)
- > Five functional blocks; Figure 4:
- **Signal Capture**: photon-induced pulses of > 3 ns duration, asynchronously captured and synchronized by 100 MHz clock.
- Multi-Channel Scaler (MCS): assigns arrival timebin to captured signals, counts the signals falling in the same time-bin.
- **Data Storage (RAM)** for histograms of photon counts (16-bit) versus time-bin index (10 000).

<u>Readout Logic</u>: supports a Serial-to-USB readout

of the RAM by the control computer.

motor sync signal ' **Control State Machine** Electric field (Trigger) Acquisition Capture External clock reference signal < Figure 4: The architecture of our DAQ system.

**FPGA** 

- Control State Machine: coordinates sub-systems, controlled by the Trigger and Diffractometer-Sync signals.
- Ext PLL (PLL) for system synchronization with external arbitrary clock sources; not a part of FPGA.

#### 4. Functional design on FPGA

Design features of the *Multi-Channel Scaler* (MCS) with 10 ns resolution; Figure 5.

- Photon hits captured by fast asynchronous logic, then synchronised with 100 MHz system clock for the timestamping.
- System capable of processing one hit per each clock cycle.
- Counting of photon hits and Read/Write memory access would take several clock cycles per hit. Therefore
  - buffering of hits for a period of eight clock cycles
  - > inside a dedicated 8 x 1 DEMUX register

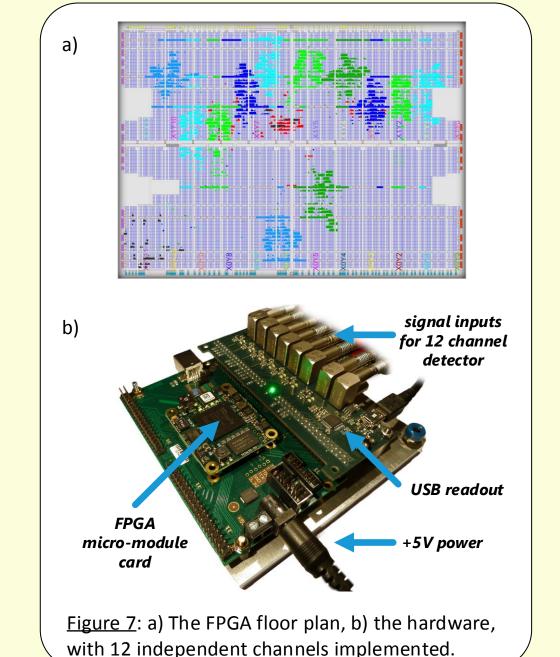
is utilised.

- Buffered hits are passed to eight parallel ADDERs, where they are summed up with counts previously gathered in the RAM.
- Parallel processing of buffered hits takes five of eight clock cycles available.
- incoming hits captured hits 100 MHz system clock synced hits 0 | 1 | 0 | 0 | 1 | 0 | 1 | 0 fetched hits **DEMUX** register **DEMUX** copy x1 | x1 8 x ADDER |x16|x16|x16|x16|x16|x16|x16|x16| RAM 8 x 16 Bit = 128 Bit RAM record Figure 5: Functional design of our 10ns resolution

Multi-Channel Scaler (MCS).

- 10 t(ns) 500 MHz clock 5 x 1 SerDes 2 ns resolution Channel 3 Channel 4 Channel 5 extension 100 MHz 100 MHz 100 MHz Ch 5 Ch 1 Ch 2 Ch 3 Ch 4 Ch 5 Ch 1 Bin: 0 Bin: 1 Bin: 1 Bin: 1 Bin: 1 Bin: 2 Figure 6: Functional design of the 2 ns resolution extension. Re-sorting of time-bins done offline
- 1 Gb/s SerDes serial-to-parallel converter used to increase resolution to 2 ns.
- SerDes clock of 500 MHz and register length of five locations; Figure 6.
- Incoming photon pulses applied on serial input into SerDes.
- Five parallel SerDes outputs mapped into five MCSs, each of 100 MHz speed.
- Every 10 ns SerDes content copied into *five* parallel running MCSs for hit counting and data storing in RAM.
- Off-line re-sorting of time-bins to a single data stream.

### Hardware implementation



#### Floor plan:

- VHDL design implemented on Xilinx® Spartan-6 LX150 FPGA chipset.
- Containing 12 independent channels; Figure 7 a.
- 37 % of configurable logic block (CLB) and
- 53 % of block RAM resources used.

#### Hardware:

- FPGA micro-module card, type TE0600 and signal fan-out card; both *Trenz Electronic* products; *Figure 7 b.*
- Home-made daughter card for I/O signals and Serial-to-USB data transmission chipset.

## 6. Experimental results

- > 10 ns resolution example from PETRA III:
- 10-channel MAD-detector installed at the Beamline P02.1.
- Our DAQ system of **10 ns resolution**.
- Powder ceramics sample, exited by 10 kHz cycles of a rectangular electric field, probed by the X-ray beam, diffraction profiles obtained.
- Overall intensity of three diffraction peaks collected by three detector channels with quarter millidegree angular resolution; Figure 8 (left).
- Time dependence of diffraction profiles measured on µs scale with 10 ns resolution; Figure 8 (right).
- > 2 ns resolution example from BESSY II:
- A fast single-point detector.
- Our DAQ system of **2 ns resolution** extension.
- Measurement of X-ray multi-bunch time structure with 2 ns bunch separation; Figure 9.

